

## General Description

The WSF34V10 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

The WSF34V10 meet the RoHS and Green Product requirement 100%  $E_{AS}$  guaranteed with full function reliability approved.

## Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- 100%  $E_{AS}$  Guaranteed
- Green Device Available

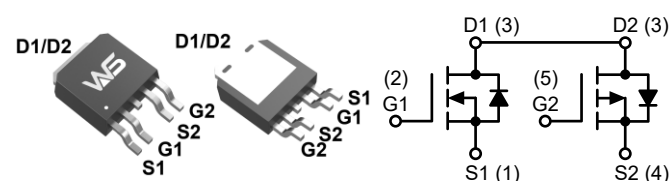
## Product Summary

| $BV_{DSS}$ | $R_{DS(ON)}$ | $I_D$ |
|------------|--------------|-------|
| 100V       | 38m $\Omega$ | 30A   |
| -100V      | 84m $\Omega$ | -26A  |

## Applications

- High Frequency Point-of-Load Synchronous Buck Converter.
- Networking DC-DC Power System
- Load Switch

## TO-252-4L Pin Configuration



## Absolute Maximum Ratings

| Symbol                               | Parameter  | Rating     |           | Units |
|--------------------------------------|--|------------|-----------|-------|
|                                      |  | N-Channel  | P-Channel |       |
| V <sub>DS</sub>                      | Drain-Source Voltage   | 100        | -100      | V     |
| V <sub>GS</sub>                      | Gate-Source Voltage  | ±20        | ±20       |       |
| I <sub>D</sub> @T <sub>A</sub> =25°C | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> | 30         | -26       | A     |
| I <sub>D</sub> @T <sub>A</sub> =70°C | Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup> | 19         | -16.1     |       |
| I <sub>DM</sub>                      | Pulsed Drain Current <sup>2</sup>                            | 90         | -85       |       |
| E <sub>AS</sub>                      | Single Pulse Avalanche Energy <sup>3</sup>                   | 138        | 147       | mJ    |
| I <sub>AS</sub>                      | Avalanche Current  | 17         | -33       | A     |
| P <sub>D</sub> @T <sub>A</sub> =25°C | Total Power Dissipation <sup>4</sup>                         | 46         | 46        | W     |
| T <sub>STG</sub>                     | Storage Temperature Range                                    | -55 to 150 |           | °C    |
| T <sub>J</sub>                       | Operating Junction Temperature Range                         | -55 to 150 |           |       |
| R <sub>θJA</sub>                     | Thermal Resistance, Junction-to-Ambient <sup>1</sup>         | 62.5       |           | °C/W  |
| R <sub>θJC</sub>                     | Thermal Resistance, Junction-to-Case <sup>1</sup>            | 2.6        |           |       |

**N-Channel Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , Unless Otherwise Noted)**

| Symbol       | Parameter                         | Conditions  | Min. | Typ. | Max.      | Units      |
|--------------|-----------------------------------|---|------|------|-----------|------------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage    | $V_{GS}=0V$ , $I_D=250\mu A$                                  | 100  | ---  | ---       | V          |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=10V$ , $I_D=10A$                                      | ---  | 38   | 50        | m $\Omega$ |
|              |                                   | $V_{GS}=4.5V$ , $I_D=6A$                                      | ---  | 42   | 58        |            |
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{GS}=V_{DS}$ , $I_D=250\mu A$                              | 1.0  | 1.5  | 2.2       | V          |
| $I_{DSS}$    | Drain-Source Leakage Current      | $V_{DS}=100V$ , $V_{GS}=0V$ , $T_J=25^{\circ}\text{C}$        | ---  | ---  | 1.0       | $\mu A$    |
| $I_{GSS}$    | Gate-Source Leakage Current       | $V_{GS}=\pm 20V$ , $V_{DS}=0V$                                | ---  | ---  | $\pm 100$ | nA         |
| $Q_g$        | Total Gate Charge                 | $V_{DS}=80V$ , $I_D=20A$ ,<br>$V_{GS}=4.5V$                   | ---  | 20   | ---       | nC         |
| $Q_{gs}$     | Gate-Source Charge                |   | ---  | 3.1  | ---       |            |
| $Q_{gd}$     | Gate-Drain Charge                 |   | ---  | 14   | ---       |            |
| $T_{d(on)}$  | Turn-On Delay Time                | $V_{DS}=80V$ , $I_D=20A$ ,<br>$R_G=3.1\Omega$ , $V_{GS}=4.5V$ | ---  | 11   | ---       | ns         |
| $T_r$        | Rise Time                         |   | ---  | 91   | ---       |            |
| $T_{d(off)}$ | Turn-Off Delay Time               |   | ---  | 40   | ---       |            |
| $T_f$        | Fall Time                         |   | ---  | 71   | ---       |            |
| $C_{iss}$    | Input Capacitance                 | $V_{DS}=25V$ , $V_{GS}=0V$ , $f=1.0\text{MHz}$                | ---  | 1964 | ---       | pF         |
| $C_{oss}$    | Output Capacitance                |   | ---  | 90   | ---       |            |
| $C_{rss}$    | Reverse Transfer Capacitance      |   | ---  | 74   | ---       |            |

**Diode Characteristics**

| Symbol   | Parameter  | Conditions                     | Min. | Typ. | Max. | Units |
|----------|--|--------------------------------|------|------|------|-------|
| $I_S$    | Maximum Continuous Drain to Source Diode Forward Current |                                | ---  | ---  | 30   | A     |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current     |                                | ---  | ---  | 80   |       |
| $V_{SD}$ | Drain to Source Diode Forward Voltage                    | $V_{GS}=0V$ , $I_S=20A$        | ---  | ---  | 1.2  | V     |
| $t_{rr}$ | Body Diode Reverse Recovery Time                         | $I_F=20A$ , $dI/dt=100A/\mu s$ | ---  | 64   | ---  | ns    |
| $Q_{rr}$ | Body Diode Reverse Recovery Charge                       |                                | ---  | 152  | ---  | nC    |

**Note:**

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,  $t \leq 10\text{sec}$ .
2. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$
3. The  $E_{AS}$  data shows Max. rating. The test condition is  $V_{DD}=80V$ ,  $V_{GS}=10V$ ,  $L=0.1\text{mH}$ ,  $I_{AS}=17A$
4. The power dissipation is limited by  $150^{\circ}\text{C}$  junction temperature.
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

**P-Channel Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , Unless Otherwise Noted)**

| Symbol       | Parameter                         | Conditions  | Min. | Typ. | Max.      | Units      |
|--------------|-----------------------------------|---|------|------|-----------|------------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage    | $V_{GS}=0V$ , $I_D=-250\mu A$                                 | -100 | ---  | ---       | V          |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=-10V$ , $I_D=-10A$                                    | ---  | 84   | 105       | m $\Omega$ |
|              |                                   | $V_{GS}=-4.5V$ , $I_D=-6A$                                    | ---  | 90   | 130       |            |
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{GS}=V_{DS}$ , $I_D=-250\mu A$                             | -1.2 | -1.6 | -2.5      | V          |
| $I_{DSS}$    | Drain-Source Leakage Current      | $V_{DS}=-100V$ , $V_{GS}=0V$ , $T_J=25^{\circ}\text{C}$       | ---  | ---  | -1.0      | $\mu A$    |
|              |                                   | $V_{DS}=-100V$ , $V_{GS}=0V$ , $T_J=100^{\circ}\text{C}$      | ---  | ---  | -100      |            |
| $I_{GSS}$    | Gate-Source Leakage Current       | $V_{GS}=\pm 20V$ , $V_{DS}=0V$                                | ---  | ---  | $\pm 100$ | nA         |
| $g_{fs}$     | Forward Transconductance          | $V_{DS}=-10V$ , $I_D=-10A$                                    | ---  | 30   | ---       | S          |
| $R_g$        | Gate Resistance                   | $V_{DS}=0V$ , $V_{GS}=0V$ , $f = 1.0\text{MHz}$               | ---  | 4.0  | ---       | $\Omega$   |
| $Q_g$        | Total Gate Charge                 | $V_{DS}=-50V$ , $V_{GS}=-10V$ ,<br>$I_D=-10A$                 | ---  | 65   | ---       | nC         |
| $Q_{gs}$     | Gate-Source Charge                |   | ---  | 10.2 | ---       |            |
| $Q_{gd}$     | Gate-Drain Charge                 |   | ---  | 13   | ---       |            |
| $T_{d(on)}$  | Turn-On Delay Time                | $V_{DS}=-50V$ , $V_{GS}=-10V$ ,<br>$R_G=3\Omega$ , $I_D=-10A$ | ---  | 12.8 | ---       | ns         |
| $T_r$        | Rise Time                         |   | ---  | 30   | ---       |            |
| $T_{d(off)}$ | Turn-Off Delay Time               |   | ---  | 82   | ---       |            |
| $T_f$        | Fall Time                         |   | ---  | 61   | ---       |            |
| $C_{iss}$    | Input Capacitance                 | $V_{DS}=-50V$ , $V_{GS}=0V$ , $f = 1.0\text{MHz}$             | ---  | 3985 | ---       | pF         |
| $C_{oss}$    | Output Capacitance                |   | ---  | 85   | ---       |            |
| $C_{rss}$    | Reverse Transfer Capacitance      |   | ---  | 71   | ---       |            |

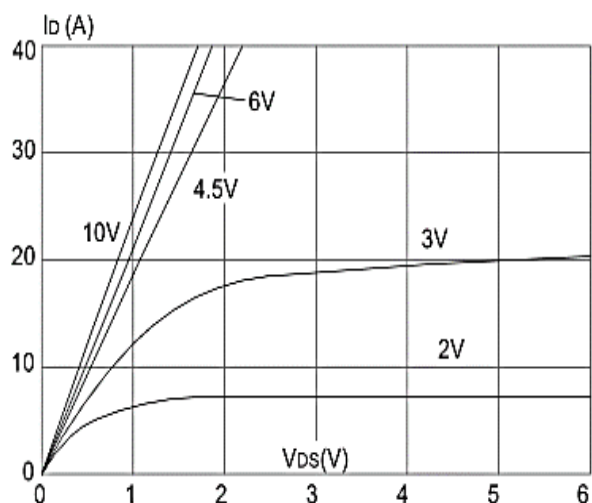
**Diode Characteristics**

| Symbol   | Parameter   | Conditions                      | Min. | Typ. | Max. | Units |
|----------|---|---------------------------------|------|------|------|-------|
| $I_S$    | Continuous Source Current, $T_J=25^{\circ}\text{C}$ | $I_S=-10A$ , $V_{GS}=0V$        | ---  | ---  | -18  | V     |
| $V_{SD}$ | Diode Forward Voltage                               |                                 | ---  | ---  | 1.2  |       |
| $t_{rr}$ | Body Diode Reverse Recovery Time                    | $I_F=-10A$ , $di/dt=100A/\mu s$ | ---  | 62   | ---  | ns    |
| $Q_{rr}$ | Body Diode Reverse Recovery Charge                  |                                 | ---  | 56   | ---  | nC    |

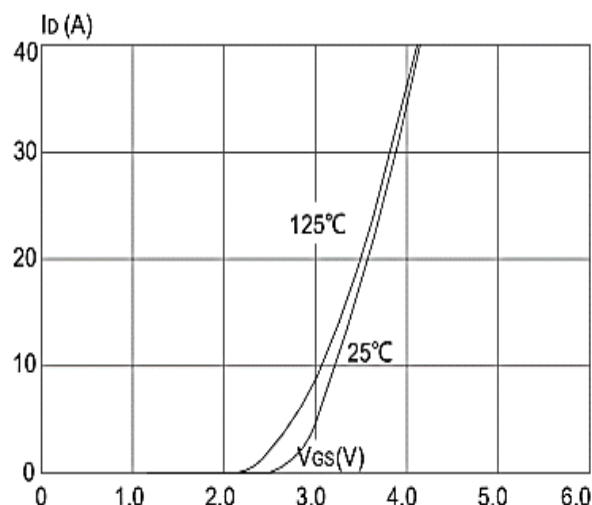
Note:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper,  $t \leq 10\text{sec}$ .
2. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$
3. The  $E_{AS}$  data shows Max. rating. The test condition is  $V_{DD}=-72V$ ,  $V_{GS}=-10V$ ,  $L=0.1\text{mH}$ ,  $I_{AS}=-33A$
4. The power dissipation is limited by  $150^{\circ}\text{C}$  junction temperature.
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

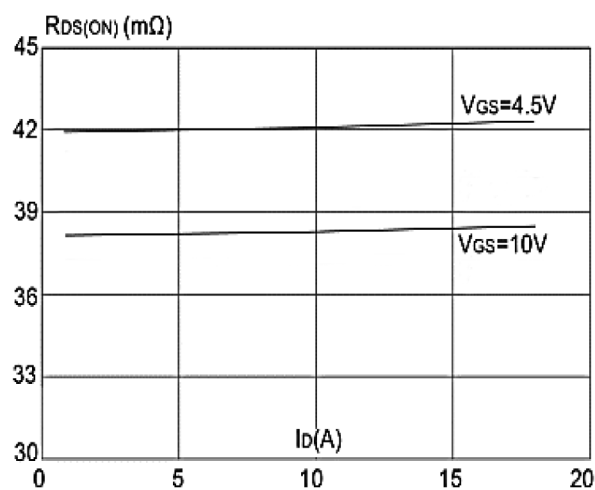
## N-Channel Typical Characteristics



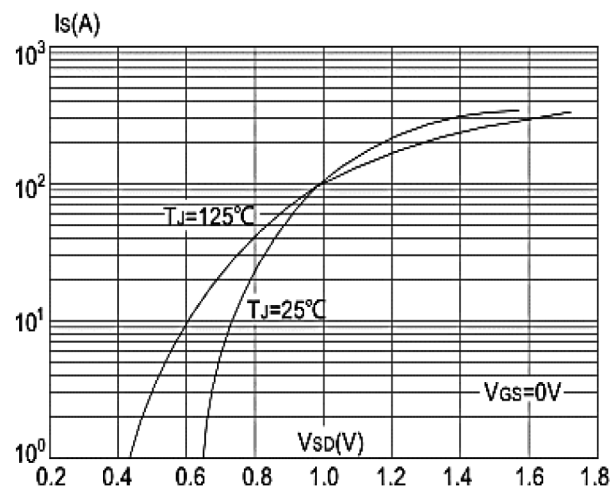
**Figure 1: Output Characteristics**



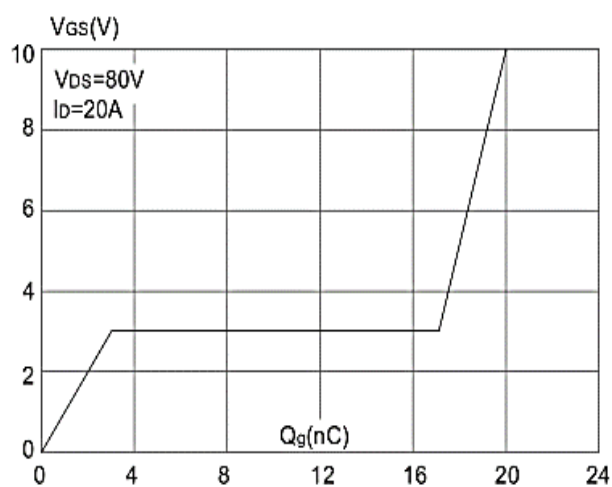
**Figure 2: Typical Transfer Characteristics**



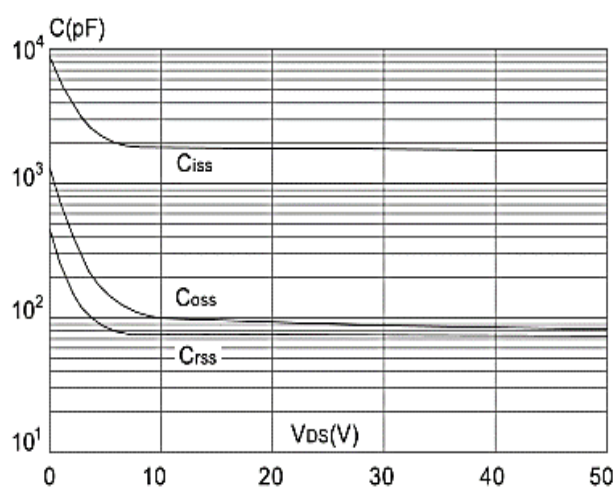
**Figure 3: On-resistance vs. Drain Current**



**Figure 4: Body Diode Characteristics**

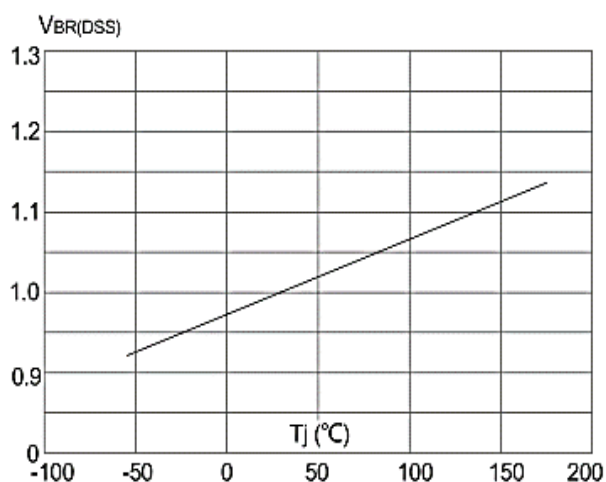


**Figure 5: Gate Charge Characteristics**

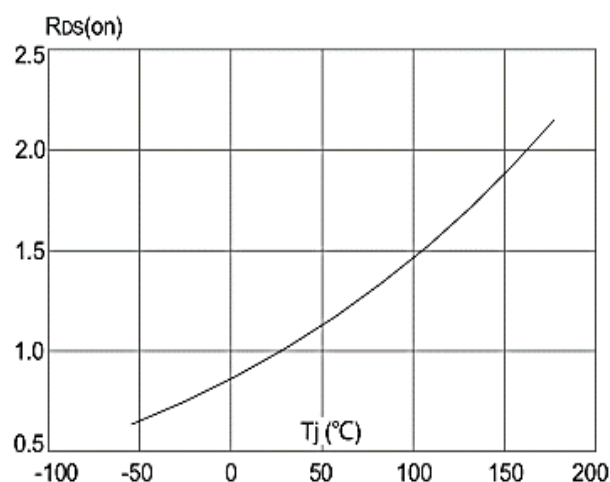


**Figure 6: Capacitance Characteristics**

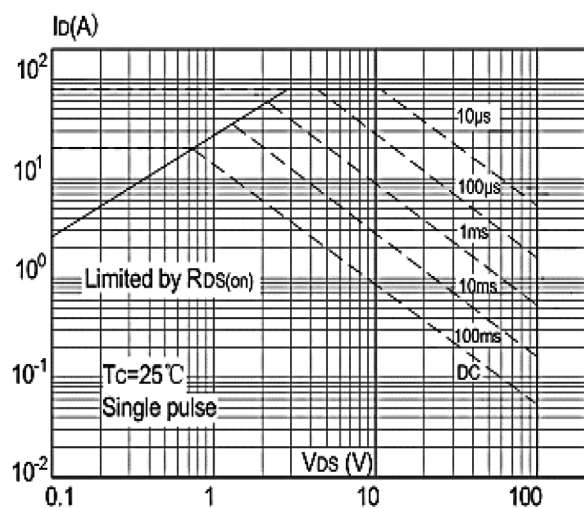
## N-Channel Typical Characteristics (Cont.)



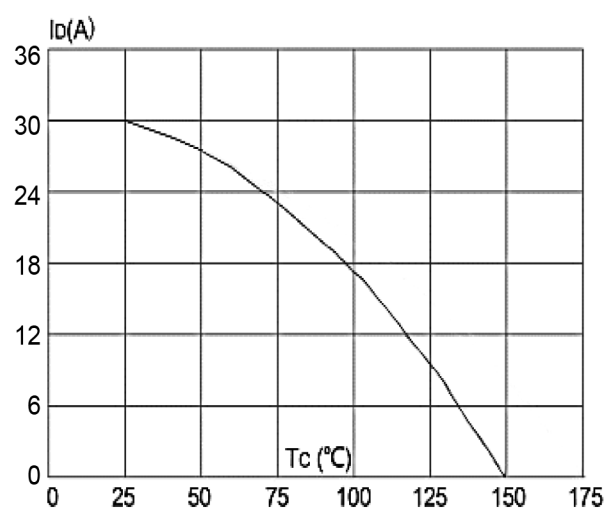
**Figure 7: Normalized Breakdown Voltage vs. Junction Temperature**



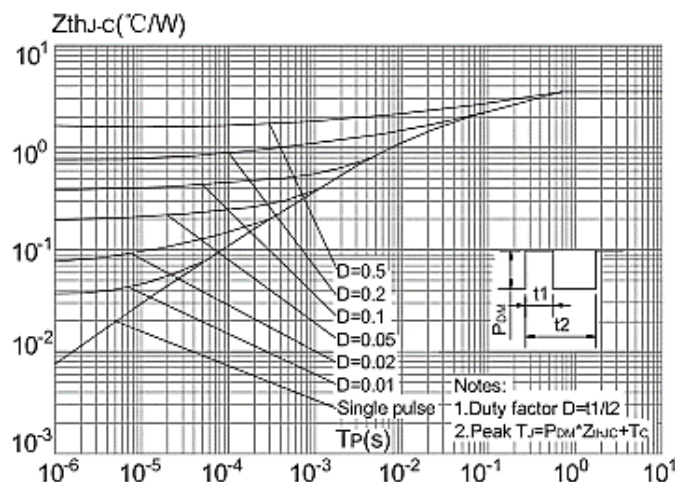
**Figure 8: Normalized on Resistance vs. Junction Temperature**



**Figure 9: Maximum Safe Operating Area vs. Case Temperature**



**Figure 10: Maximum Continuous Drain Current**



**Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case**

## P-Channel Typical Characteristics

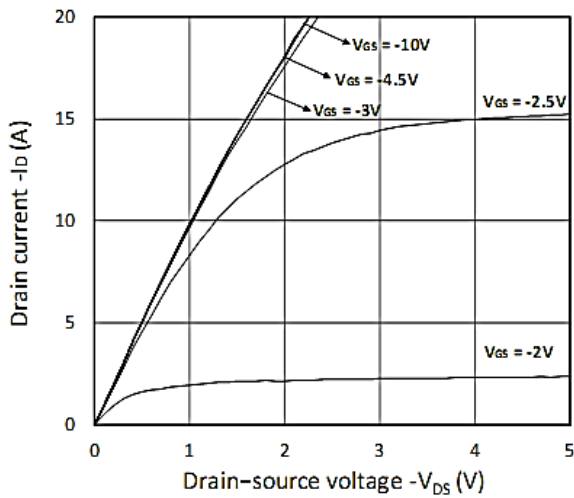


Figure 1. Output Characteristics

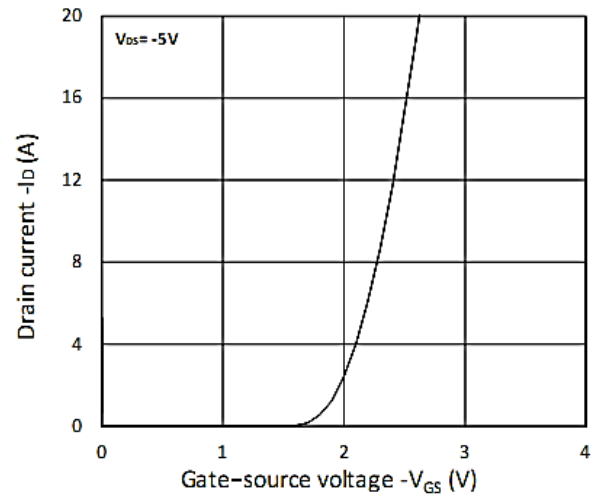


Figure 2. Transfer Characteristics

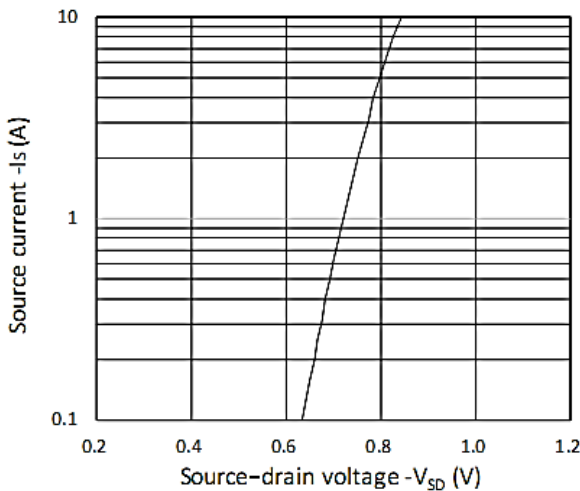


Figure 3. Forward Characteristics of Reverse

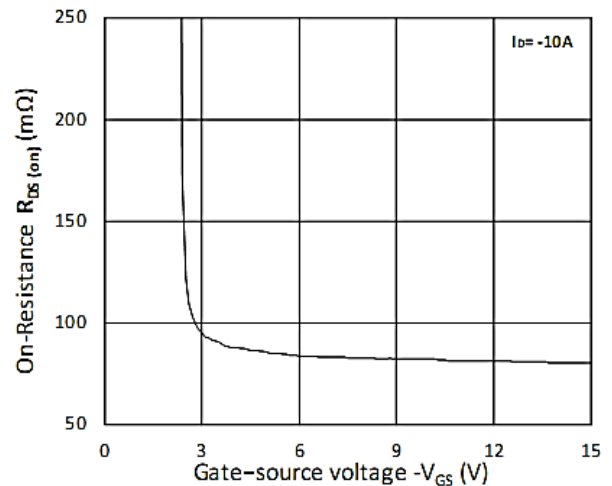


Figure 4.  $R_{DS(ON)}$  vs.  $V_{GS}$

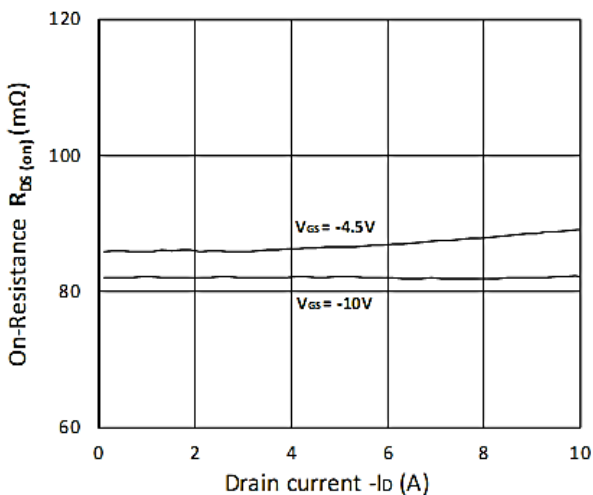


Figure 5.  $R_{DS(ON)}$  vs.  $I_D$

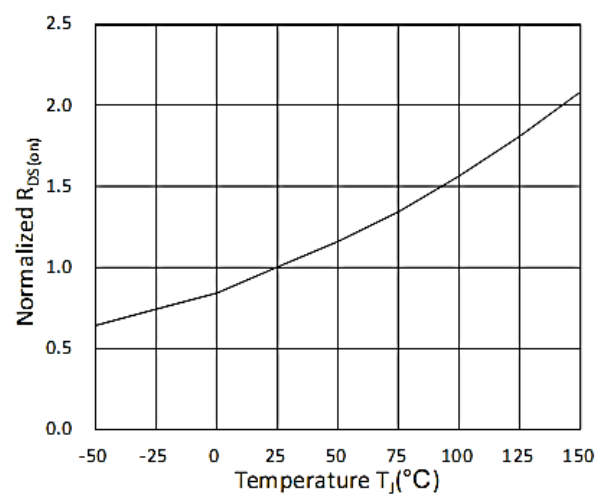
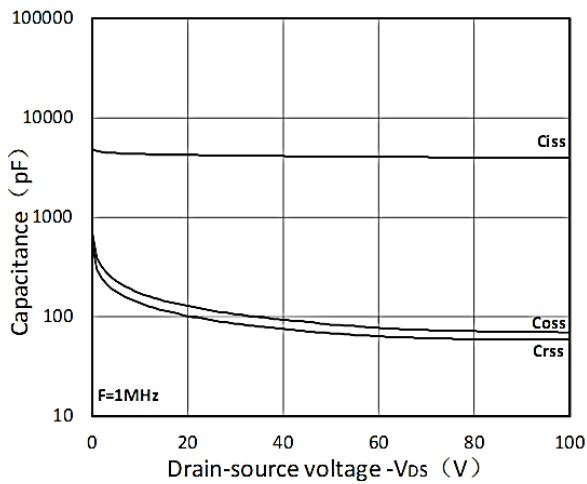
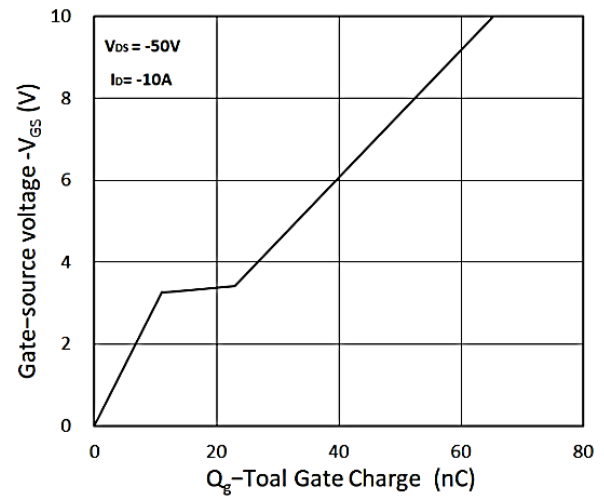
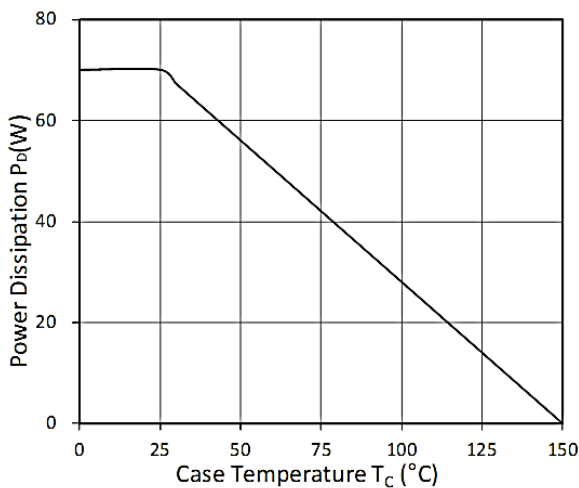
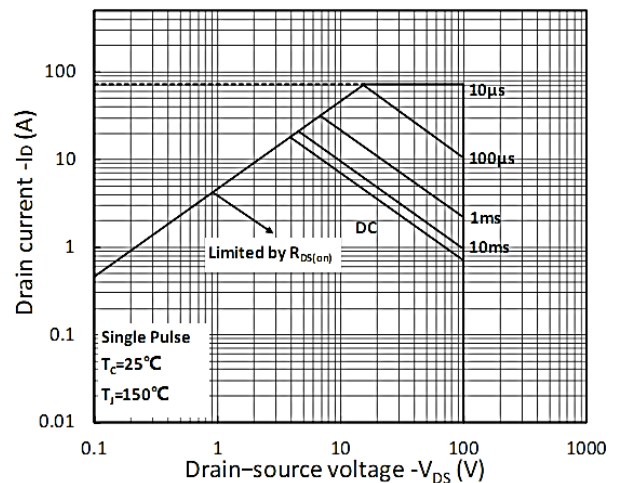
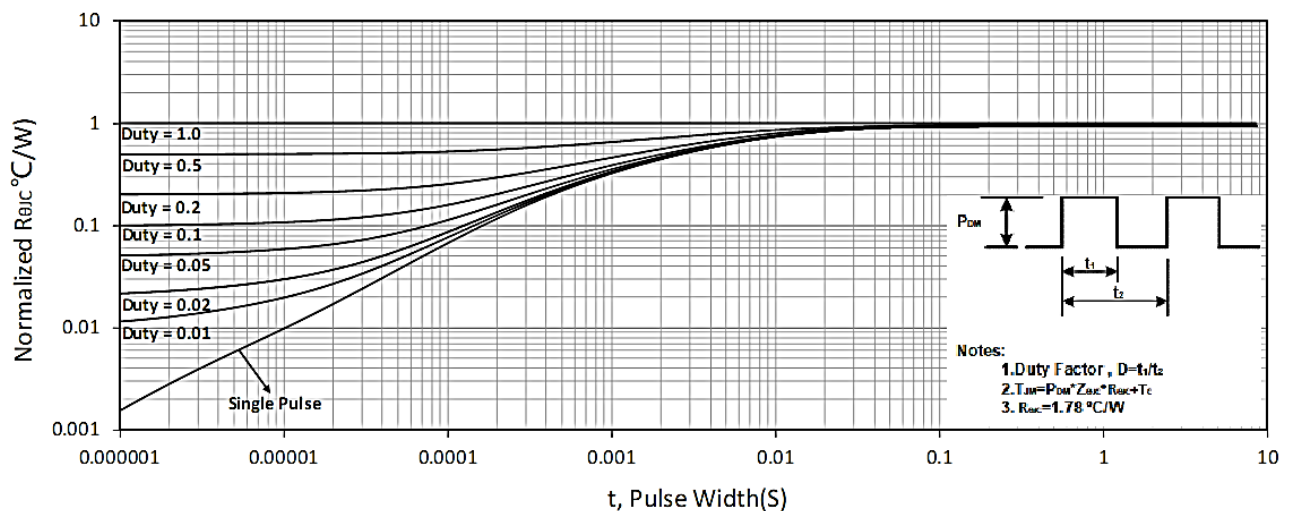
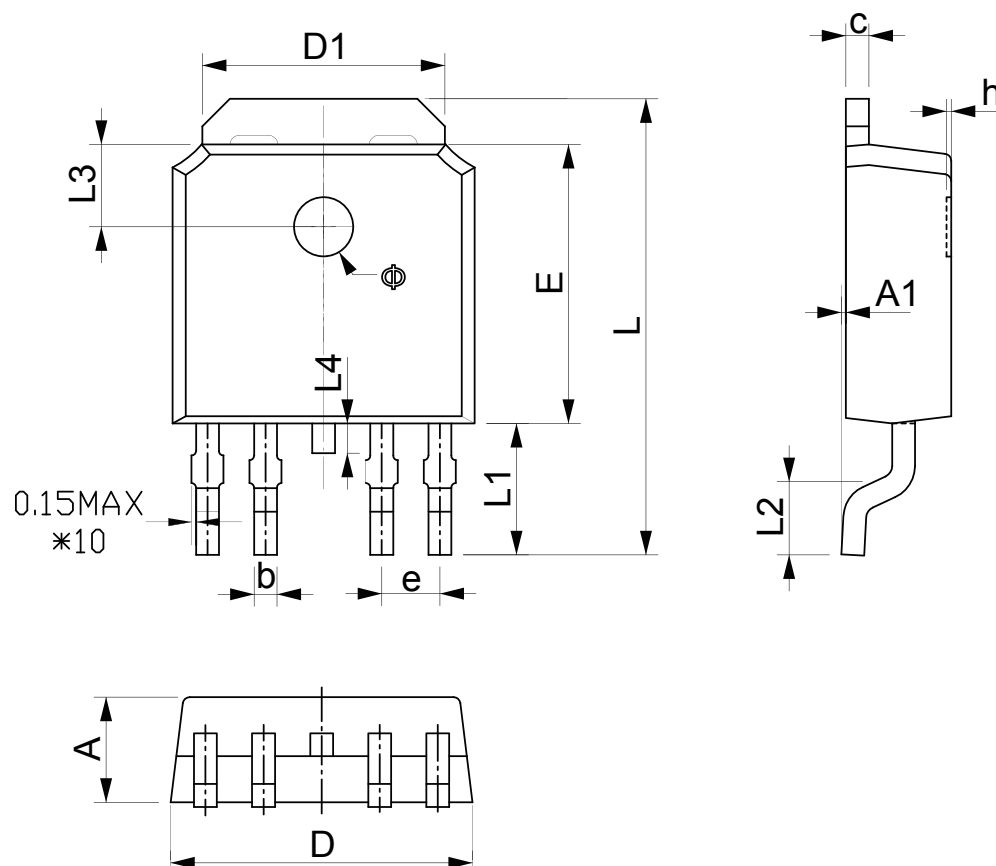


Figure 6. Normalized  $R_{DS(on)}$  vs. Temperature

**P-Channel Typical Characteristics (Cont.)**

**Figure 7. Capacitance Characteristics**

**Figure 8. Gate Charge Characteristics**

**Figure 9. Power Dissipation**

**Figure 10. Safe Operating Area**

**Figure 11. Normalized Maximum Transient Thermal Impedance**



## Packaging information



| Symbol | Dimensions In Millimeters |        | Dimensions In Inches |       |
|--------|---------------------------|--------|----------------------|-------|
|        | Min.                      | Max.   | Min.                 | Max.  |
| A      | 2.200                     | 2.400  | 0.087                | 0.094 |
| A1     | 0.000                     | 0.127  | 0.000                | 0.005 |
| b      | 0.400                     | 0.600  |                      |       |
| c      | 0.460                     | 0.580  | 0.018                | 0.023 |
| D      | 6.500                     | 6.700  | 0.256                | 0.264 |
| D1     | 5.100                     | 5.460  | 0.201                | 0.215 |
| D2     | 4.830 REF.                |        | 0.190 REF.           |       |
| E      | 6.000                     | 6.200  | 0.236                | 0.244 |
| e      | 2.186                     | 2.386  | 0.086                | 0.094 |
| L      | 9.712                     | 10.312 | 0.382                | 0.406 |
| L1     | 2.900 REF.                |        | 0.114 REF.           |       |
| L2     | 1.400                     | 1.700  | 0.055                | 0.067 |
| L3     | 1.600 REF.                |        | 0.063 REF.           |       |
| L4     | 0.600                     | 1.000  | 0.024                | 0.039 |
| Φ      | 1.100                     | 1.300  | 0.043                | 0.051 |
| h      | 0.000                     | 0.300  | 0.000                | 0.012 |



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